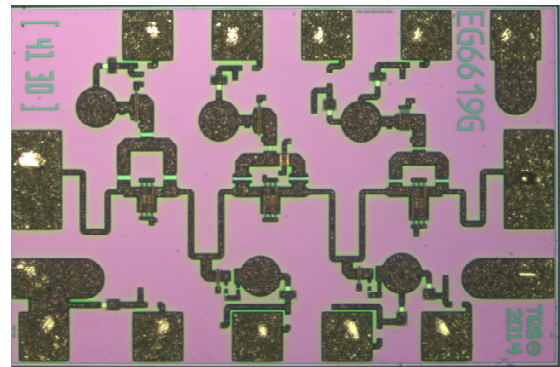


Applications

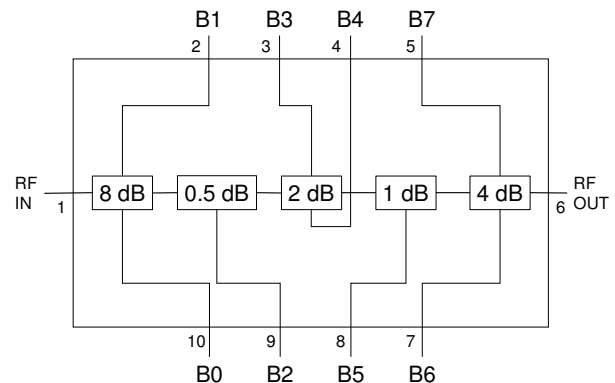
- Commercial and Military Radar
- Electronic Warfare
- Satellite Communications
- Point to Point Radio
- General Purpose



Product Features

- Frequency Range: 0.1-31 GHz
- 5-Bit Digital Attenuator
- Attenuation Step Size (LSB): 0.5 dB
- Attenuation Range: 15.5 dB
- Insertion Loss (Ref. State): 1.8-4.2 dB
- RMS Attenuation Error: < 0.9 dB
- RMS Step Error: < 0.4 dB
- Control Voltage: -3.3 to -5.0 V
- Die Size: 1.180 x 0.800 x 0.100 mm

Functional Block Diagram



General Description

TriQuint's TGL2223 is a wideband, 5-bit digital attenuator using TriQuint's TQPHT15 production 0.15um GaAs pHEMT process. Operating from 0.1 - 31 GHz, the TGL2223 offers a low LSB of 0.5 dB and supports > 15.5 dB of attenuation range with a low RMS step error of < 0.5 dB.

Using standard, negative control voltages from -3.3 to -5 V coupled with excellent broadband performance, the TGA2223 is ideal for supporting of a variety of commercial and military applications.

The TGL2223 is in die form, 1.180 x 0.800 x 0.100 mm, with both RF ports matched to 50 ohms for simple system integration.

Lead-free and RoHS compliant.

Evaluation Boards available on request.

Pad Configuration

| Pad Number | Symbol |
|------------|------------------------------------|
| 1 | RF Input |
| 2 | Compl. control line for 8.0 dB bit |
| 3 | Compl. control line for 2.0 dB bit |
| 4 | Compl. control line for 2.0 dB bit |
| 5 | Compl. control line for 4.0 dB bit |
| 6 | RF Output |
| 7 | Compl. control line for 4.0 dB bit |
| 8 | Control line for 1.0 dB bit |
| 9 | Control line for 0.5 dB bit |
| 10 | Compl. control line for 8.0 dB bit |

Ordering Information

| Part | ECCN | Description |
|---------|-------|-------------------------------------|
| TGL2223 | EAR99 | 0.1-31 GHz 5-Bit Digital Attenuator |

Absolute Maximum Ratings

| Parameter | Value |
|----------------------------------|--------|
| Control Voltage (V_C) | -6 V |
| Control Current (I_C) | 1 mA |
| Input Power (P_{IN}) | 30 dBm |
| Power Dissipation (P_{DISS}) | 0.7 W |
| Operating Channel Temperature | 150 °C |

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

| Parameter | Value |
|---------------------------|--------------|
| Control Voltage (logic L) | -3.3 to -5 V |
| Control Voltage (logic H) | 0 V |

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications

Test conditions, unless otherwise noted: 25 °C, $V_C = 0 / -5.0$ V. Tested with DUT on EVB

| Parameter | Min | Typical | Max | Units |
|--------------------------------------------------------------------------------|-----|---------|-----|-------|
| Frequency Range | 0.1 | | 31 | GHz |
| LSB Attenuation | | 0.5 | | dB |
| Attenuation range | | 15.5 | | dB |
| Reference State Insertion Loss: 1-6 GHz | | < 1.9 | | dB |
| Reference State Insertion Loss: 6-18 GHz | | < 2.7 | | dB |
| Reference State Insertion Loss: 18-31 GHz | | < 4.2 | | dB |
| Input Return Loss | | > 12 | | dB |
| Output Return Loss | | > 9 | | dB |
| IIP3 ($\Delta f = 1.0$ MHz, $P_{IN}/\text{Tone} = 5$ dBm, 14 GHz, all states) | | > 26 | | dBm |
| Switching Speed (10%-90%, 90%-10%) | | < 30 | | ns |
| RMS Attenuation Error | | < 0.9 | | dB |
| RMS Step Error | | < 0.4 | | dB |
| Max. Attenuation Error | | < 2.4 | | dB |

Specifications

Thermal and Reliability Information

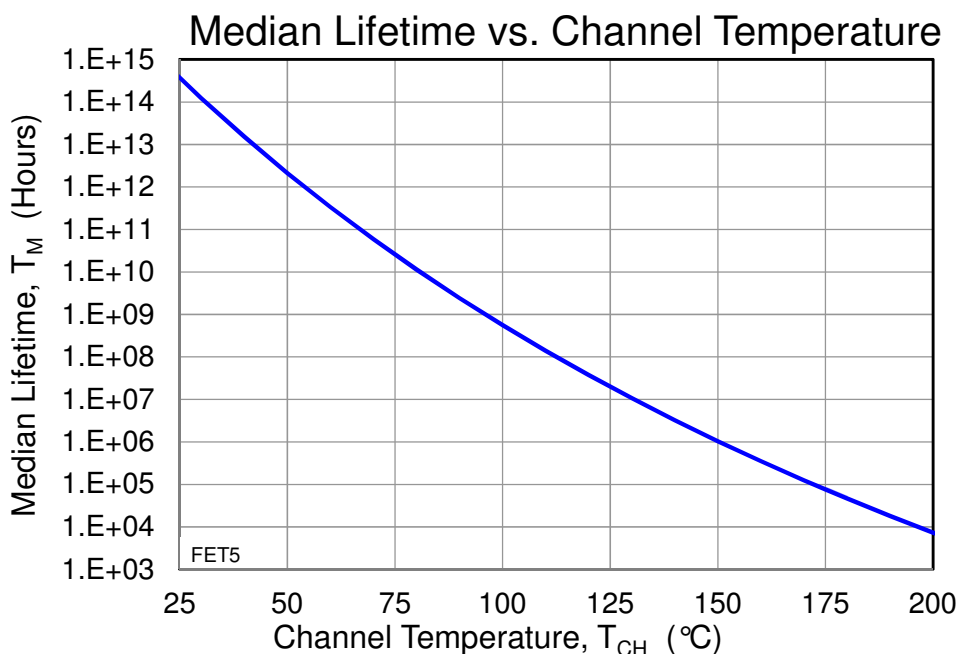
| Parameter | Conditions | Value | Units |
|-----------------------------------------------------|----------------------------------------------------------------------------------------------|---------|----------------------|
| Thermal Resistance (θ_{JC}) ⁽¹⁾ | $T_{BASE} = 85\text{ }^{\circ}\text{C}$, $V_C = -5.0\text{ V}$, $P_{DISS} = 0.22\text{ W}$ | 103.6 | $^{\circ}\text{C/W}$ |
| Channel Temperature (T_{CH}) ⁽¹⁾ | | 108 | $^{\circ}\text{C}$ |
| Median Lifetime (T_M) | | 2.24E08 | Hrs |

Note:

- 1. Carrier plate backside temperature fixed at 85 $^{\circ}\text{C}$.

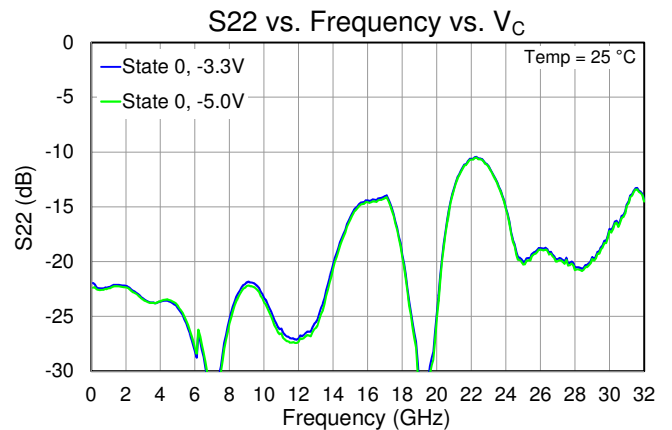
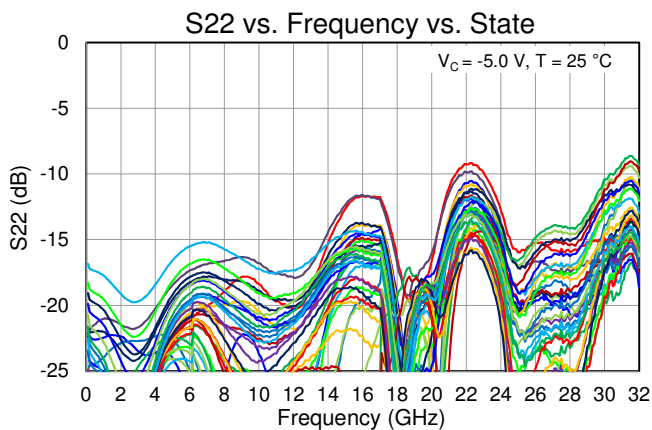
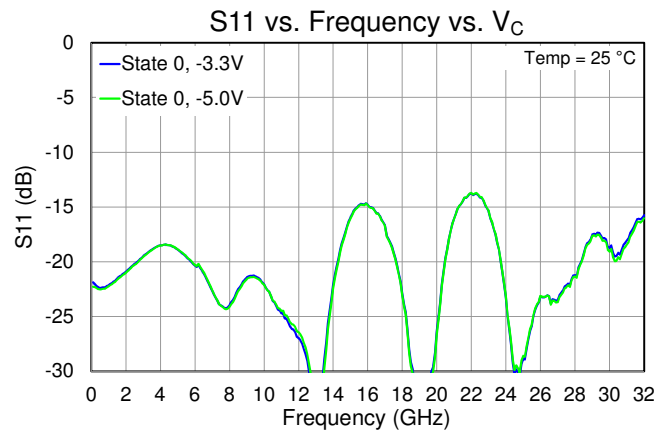
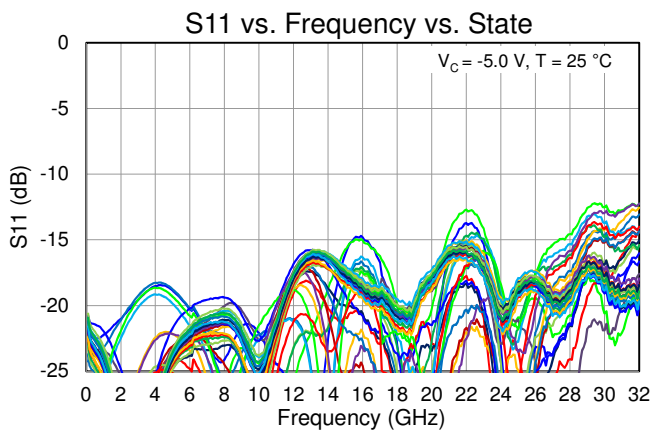
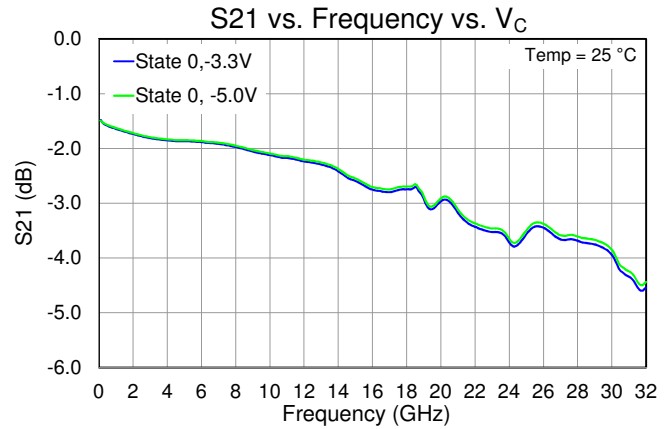
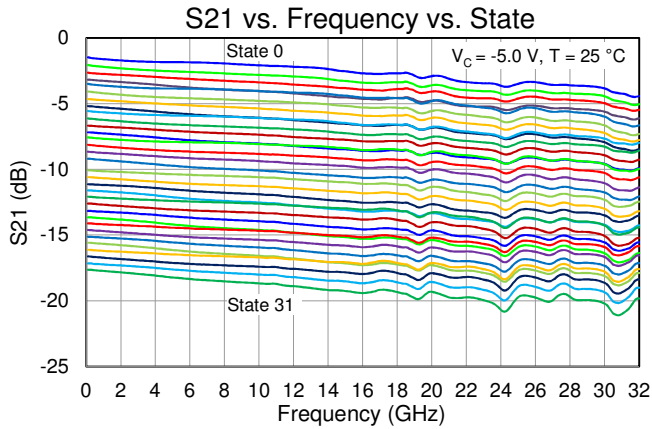
Median Lifetime

Test Conditions: 6.0 V; Failure Criterion = 10% reduction in $I_{D\text{ MAX}}$



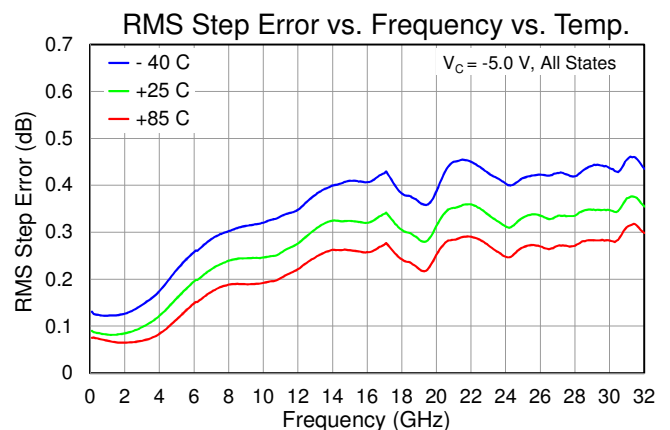
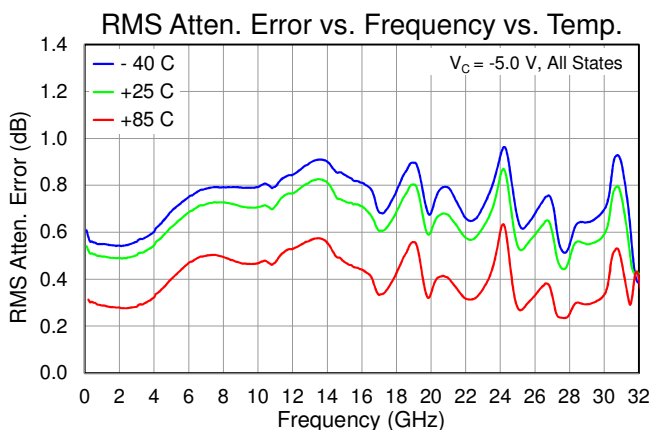
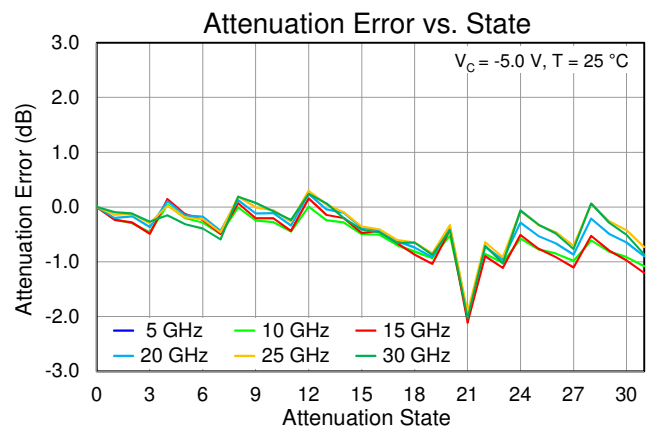
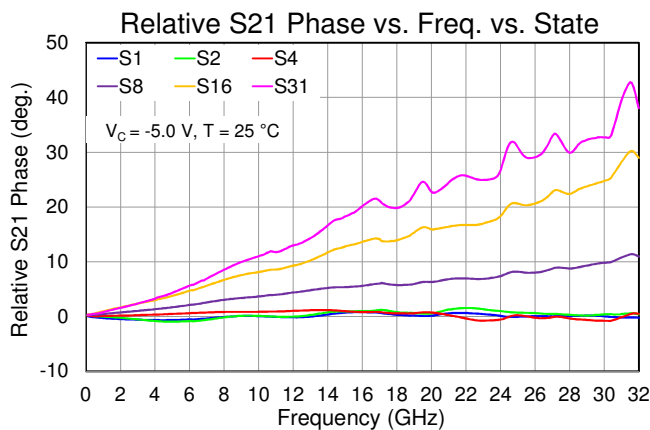
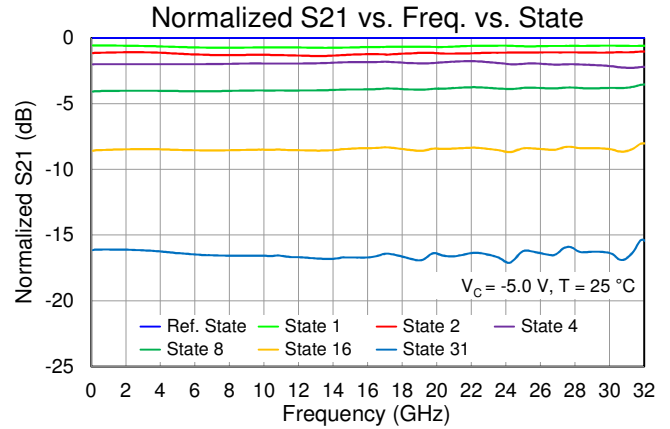
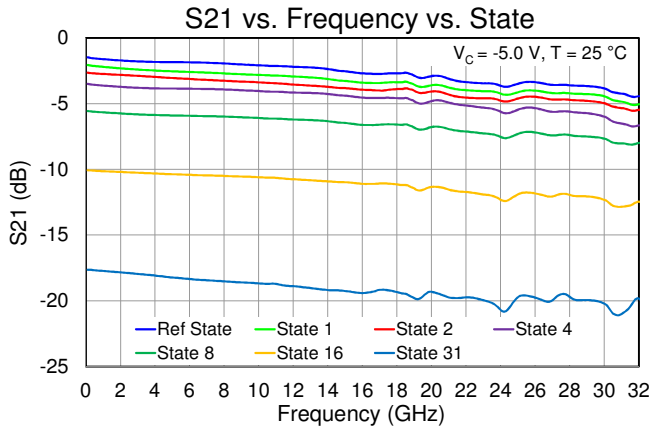
Typical Performance

Test conditions unless otherwise noted: Tested with DUT on EVB



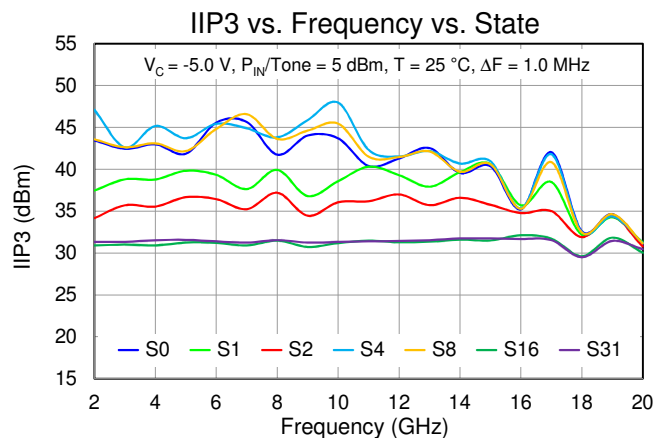
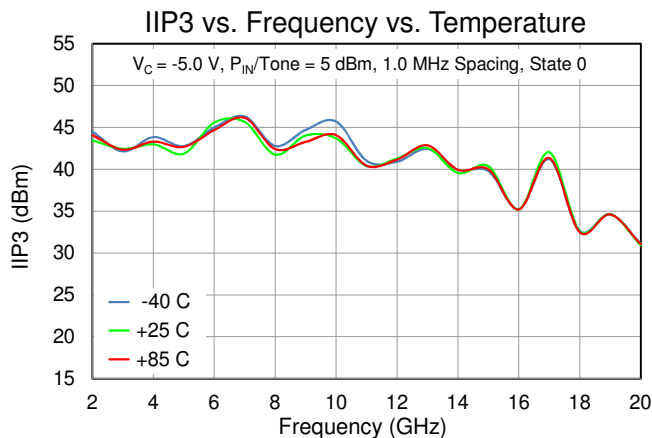
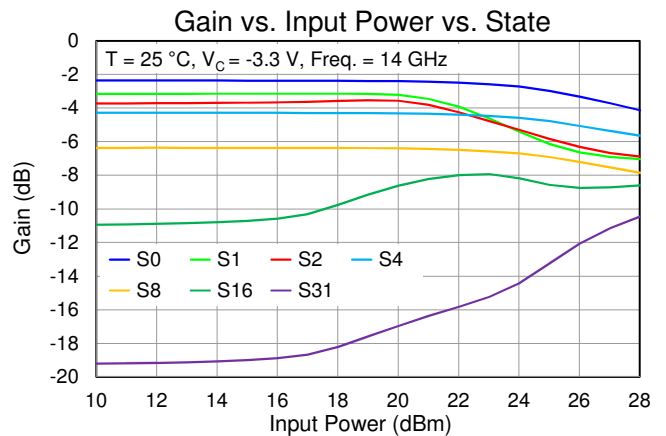
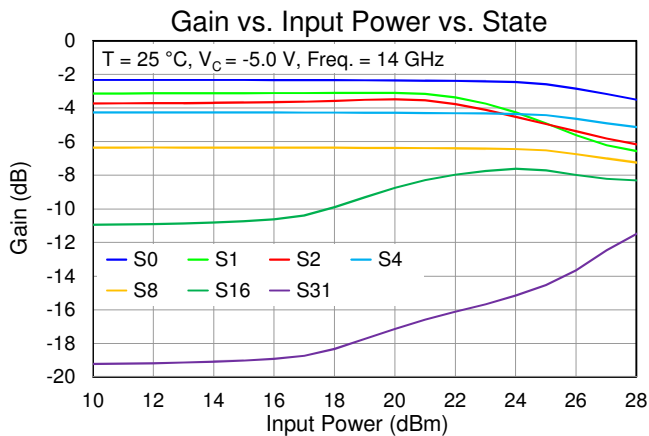
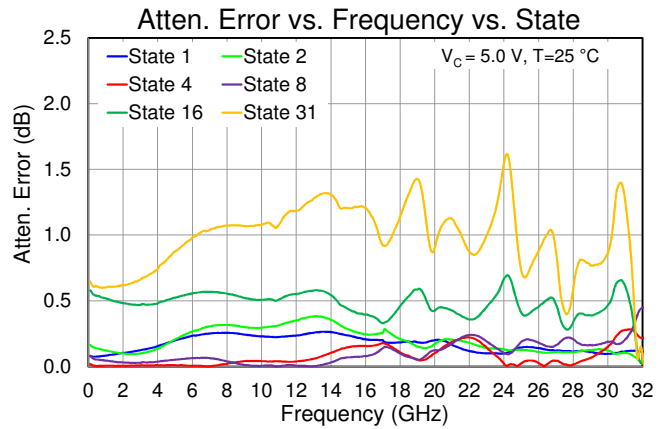
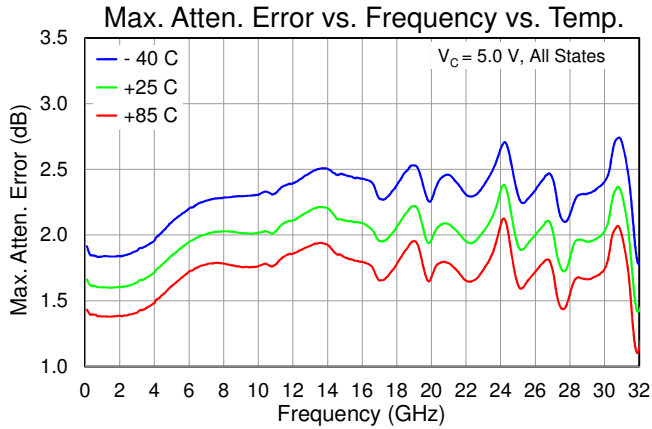
Typical Performance

Test conditions unless otherwise noted: Tested with DUT on EVB

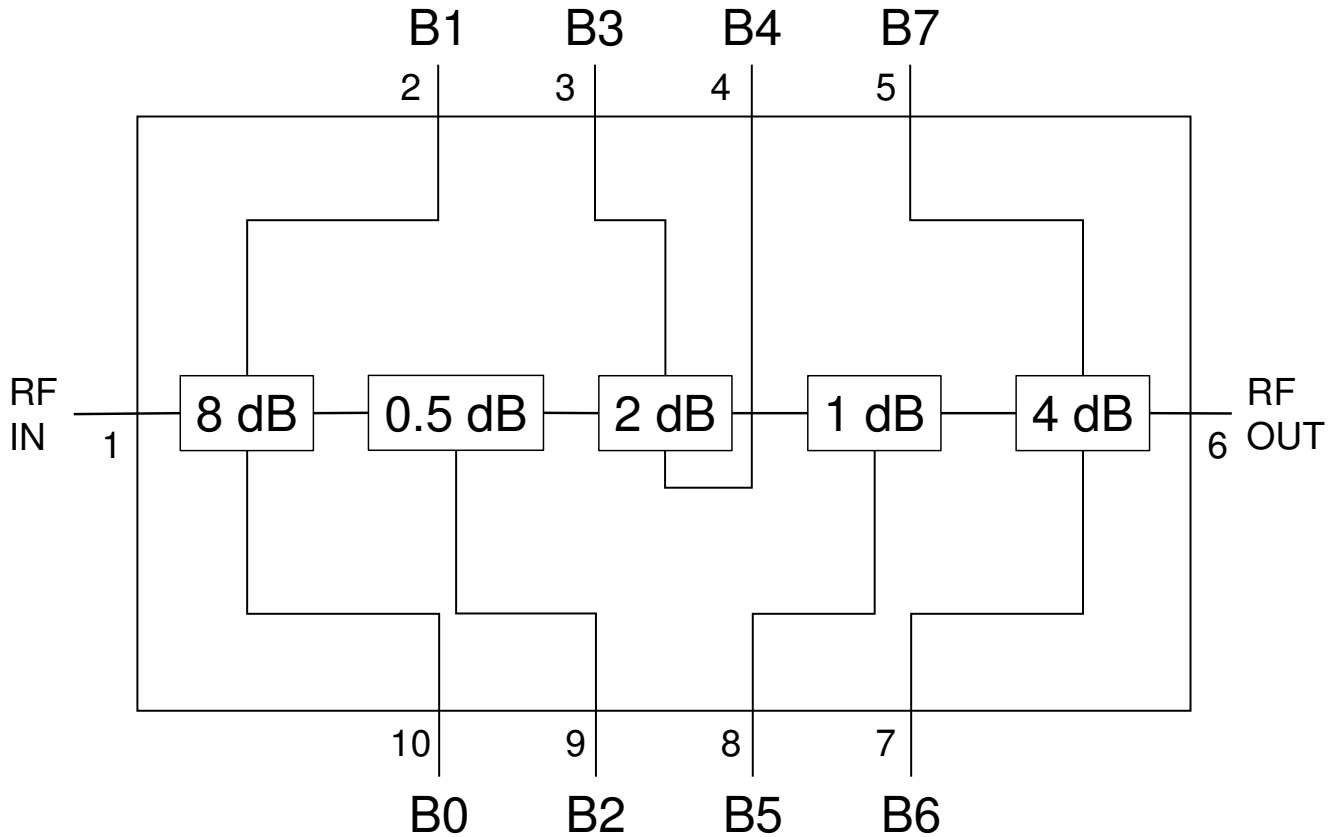


Typical Performance

Test conditions unless otherwise noted: Tested with DUT on EVB



Application Circuit



Function Table – Major States

| Parameter | State | B0 | B1 | B2 | B3 | B4 | B5 | B6 | B7 |
|---------------------------------|----------|----|----|----|----|----|----|----|----|
| 0.0 dB Attenuation (Ref. State) | State 0 | 1 | 0 | 0 | 0 | 1 | 0 | 1 | 0 |
| 0.5 dB Attenuation | State 1 | 1 | 0 | 1 | 0 | 1 | 0 | 1 | 0 |
| 1.0 dB Attenuation | State 2 | 1 | 0 | 0 | 0 | 1 | 1 | 1 | 0 |
| 2.0 dB Attenuation | State 4 | 1 | 0 | 0 | 1 | 0 | 0 | 1 | 0 |
| 4.0 dB Attenuation | State 8 | 1 | 0 | 0 | 0 | 1 | 0 | 0 | 1 |
| 8.0 dB Attenuation | State 16 | 0 | 1 | 0 | 0 | 1 | 0 | 1 | 0 |
| 15.5 dB Attenuation | State 31 | 0 | 1 | 1 | 1 | 0 | 1 | 0 | 1 |

Intermediate attenuation states are combinations of the above major states.
Logic H = 0V. Logic L = -3.3 to -5.0 V

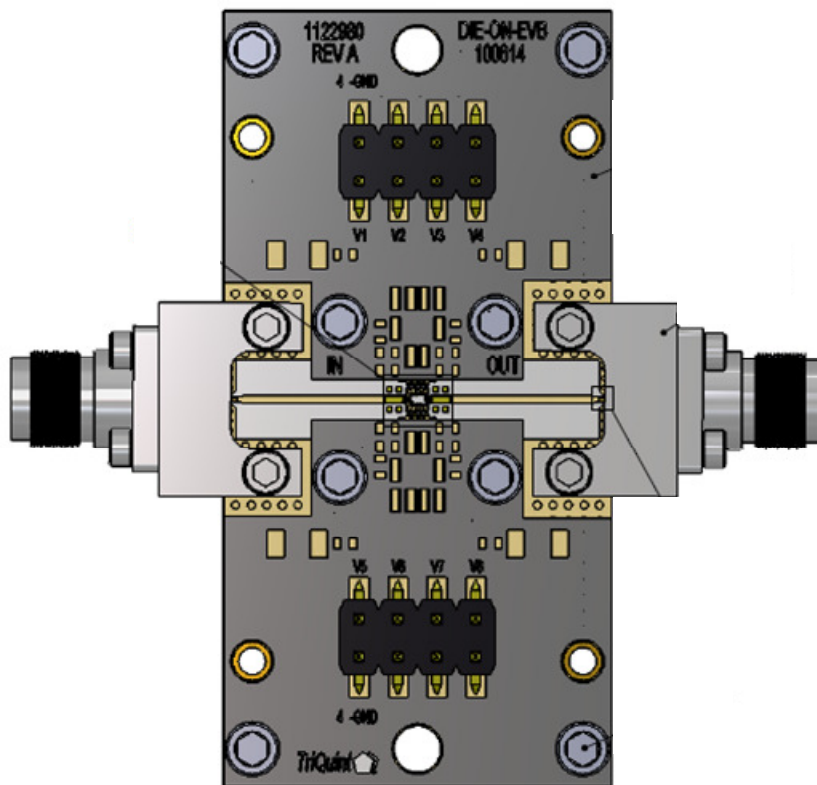
Note: RF Input and RF Output are both DC coupled.

Applications Information

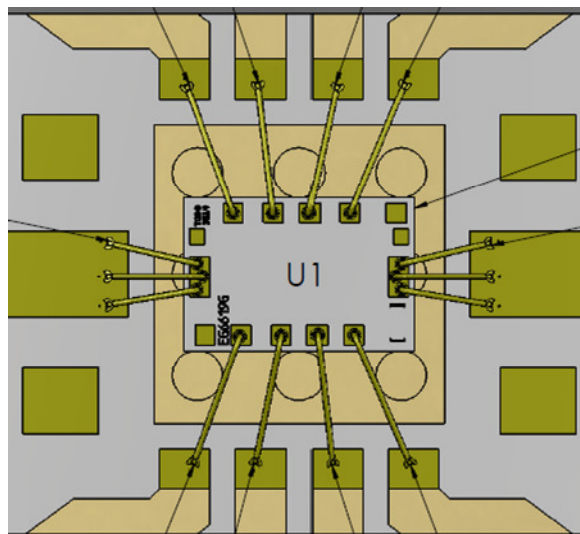
Evaluation Board Layout

RF Layer is 0.008" thick Rogers Corp. RO4003C, $\epsilon_r = 3.38$. Metal layers are 0.5 oz. copper. The microstrip line at the connector interface is optimized for the Southwest Microwave end launch connector 1092-01A-5.

The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances. Since surface mount processes vary from company to company, careful process development is recommended.

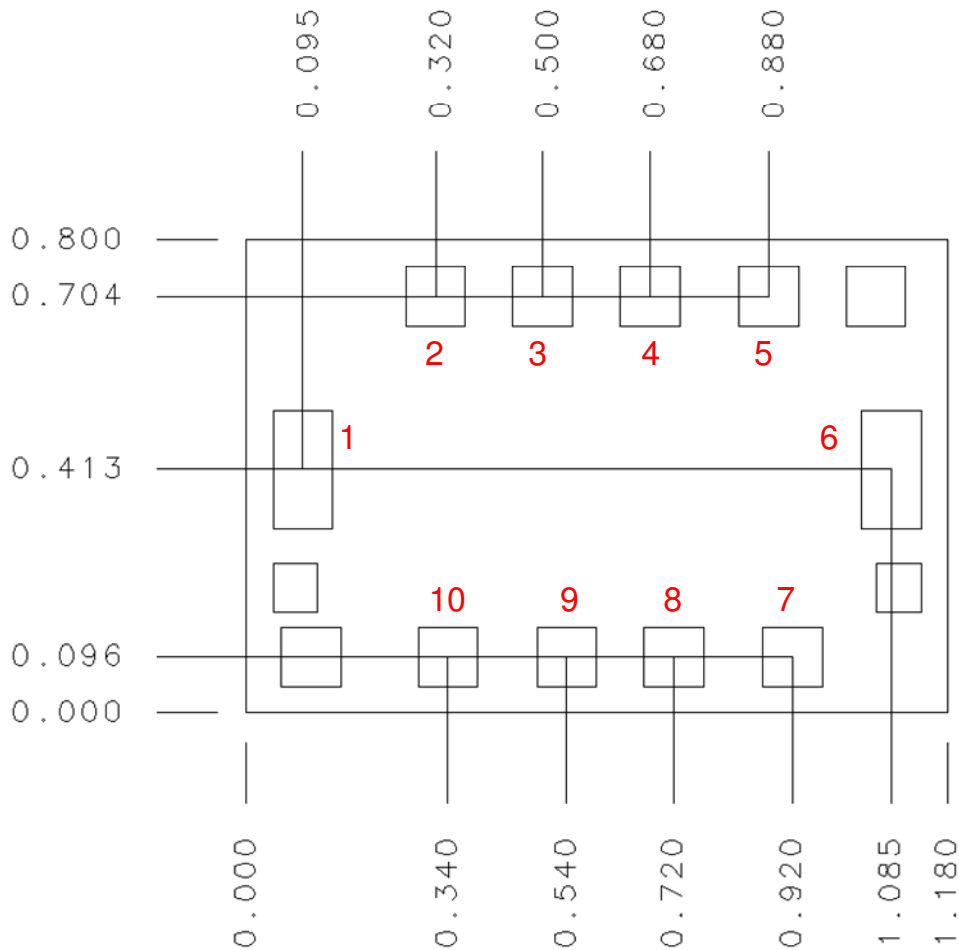


EVB Die Mounting Detail



Note:
Multiple vias should be employed under die to minimize inductance and thermal resistance.

Mechanical Drawing and Bond Pad Description



| Pin No. | Symbol | Description | Pad Size (um x um) |
|---------|-----------|-------------------------------------------|--------------------|
| 1 | RF Input | RF Input | 100 x 200 |
| 2 | B1 | Complementary control line for 8.0 dB bit | 100 x 100 |
| 3 | B3 | Complementary control line for 2.0 dB bit | 100 x 100 |
| 4 | B4 | Complementary control line for 2.0 dB bit | 100 x 100 |
| 5 | B7 | Complementary control line for 4.0 dB bit | 100 x 100 |
| 6 | RF Output | RF Output | 100 x 200 |
| 7 | B6 | Complementary control line for 4.0 dB bit | 100 x 100 |
| 8 | B5 | Control line for 1.0 dB bit | 100 x 100 |
| 9 | B2 | Control line for 0.5 dB bit | 100 x 100 |
| 10 | B0 | Complementary control line for 8.0 dB bit | 100 x 100 |

Assembly Notes

Component placement and adhesive attachment assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.
- Organic attachment (i.e., conductive epoxy) can be used in low-power applications.
- Curing should be done in a convection oven; proper exhaust is a safety concern.

Reflow process assembly notes:

- Use AuSn (80/20) solder and limit exposure to temperatures above 300°C to 3-4 minutes, maximum.
- An alloy station or conveyor furnace with reducing atmosphere should be used.
- Do not use any kind of flux.
- Coefficient of thermal expansion matching is critical for long-term reliability.
- Devices must be stored in a dry nitrogen atmosphere.

Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonics are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

Product Compliance Information

ESD Sensitivity Ratings



Caution! ESD-Sensitive Device

ESD Rating: TBD
Value: TBD
Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

ECCN

US Department of Commerce: EAR99

Solderability

Use only AuSn (80/20) solder and limit exposure to temperatures above 300 °C to 3-4 minutes, maximum.

Conductive epoxy die attach is recommended for PCBs.

RoHS-Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C15H12Br4O2) Free
- PFOS Free
- SVHC Free

Contact Information

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